Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/618;617	NAKAO ET AL.
Examiner	Art Unit
Khanh Tran	2611

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	261,264 328	9/24/2007	кст
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
375	all cited	09/24/2007	кст
370	all cited		
455	all cited		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Update EAST Searches	9/24/2007	кст
Update Inventor name Searches		,
NPL Searches		
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